

15.1.0 ANALOGUE ELECTRONICS I

15.1.01 Introduction

Analogue electronics is a study that deals with electronic systems with a continuously variable signal. This module unit is intended to impart knowledge, skills and attitudes required to enable the trainee understand the principles of operations of various electrical circuits, equipment and devices in the industries. This unit forms a foundation for Analogue Electronics II in Module II.

15.1.02 General Objectives

At the end of the module unit, the trainee should be able to:

- Understand the operation of analogue electronic devices
- Apply analogue electronic components in the construction of power supply units and other electronic devices
- Observe safety when using analogue electronic components and devices

15.1.1 Module Unit Summary and Time Allocation

Analogue Electronics I

| Code | Module Unit | Content | Time Hrs |
|--------|-------------------------|---|----------|
| 15.1.1 | Atomic Theory of matter | <ul style="list-style-type: none">Atomic structureEnergy levels | 8 |
| 15.1.2 | Thermionic Emission | <ul style="list-style-type: none">Principles of the CRTAdvantages and limitations of valvesMotions of electronsPrinciples of the CROApplications of thermionic emission | 10 |
| 15.1.3 | Semi conductor theory | <ul style="list-style-type: none">Intrinsic semi conductor.Effect of temperature on intrinsic semiconductorDoping p and n typesFormation of extrinsic | 8 |

| | | semiconductor | |
|-------------------|------------------------------|---|-----------|
| 15.1.4 | Semi-conductor diodes | <ul style="list-style-type: none"> • PN junction diode • Forward and reverse bias of pn junction diodes • Applications of pn junction diodes | 10 |
| 15.1.5 | Bipolar Junction Transistors | <ul style="list-style-type: none"> • Operation of NPN and PNP • Characteristics • Biasing methods • Determination of gains using Dc/ac load-lines | 8 |
| 15.1.6 | Field Effect Transistor | <ul style="list-style-type: none"> • Operation of field effect transistors • Biasing methods • Determination of gains using dc/ac load-lines | 10 |
| 15.1.7 | Power supply units | <ul style="list-style-type: none"> • Transformation • Rectification • Filtering • Stabilization • Regulation • Voltage multiplication • Power conversion | 12 |
| Total Time | | | 66 |

15.1.1 ATOMIC THEORY OF MATTER

Theory

15.1.1T0 *Specific Objectives*

By the end of the sub module unit the trainee should be able to:

- a) explain atomic structure
- b) explain energy level of an Atom

Content

15.1.1T1 Explanation of atomic structure

- i) The atom
- ii) Rutherford's atomic model
- iii) Plank's quantum Theory of radiation
- iv) Bohr's model

15.1.1T2 Explain the energy levels

- i) Energy level diagram
- ii) Collision of electrons and atoms
- iii) Photons of light
- iv) Spectral lines
- v) Photo ionization
- vi) Conduction band
- vii) Valence band
- viii) Forbidden gap

15.1.2 THERMIONIC EMISSION

Theory

15.1.2T0 *Specific Objectives*

By the end of the sub module unit the trainee should be able to:

- a) explain principles of thermionic emission

- b) state the advantages and limitations of valves in electronic industry
- c) explain the motion of electrons in a magnetic and electrostatic field
- d) describe the construction and operation of a Cathode Ray Tube (CRT)
- e) describe the construction and operation of a Cathode Ray Oscilloscope (CRO)
- f) explain the application of thermionic emission

Content

15.1.2T1 Principles of thermionic emission

- i) Work function
- ii) Space charge
- iii) Direct and indirect heating
- iv) Electron emitting materials

15.1.2T2 Applications and limitations of valves

15.1.2T3 Motion of electrons in magnetic and electrostatic fields

- i) Force
- ii) Deflection in transverse field
- iii) Magnetic field deflection
- iv) Electrostatic field deflection
- v) Electron velocity
- vi) Deflection of an electron beam

15.1.2T4 Cathode Ray Tube

- i) Construction
- ii) Operation
- iii) Application

15.1.2T5 Cathode Ray Oscilloscope

- i) Describe the construction by block diagram
 - ii) Describe the operation
- 15.1.2T6 Applications

Practice

- 15.1.2P0 *Specific Objectives*
By the end of the sub module unit, the trainee should be able to:
- a) operate a cathode-ray oscilloscope (CRO)
 - b) take measurements using a CRO

Content

- 15.1.2P1 Operating a CRO
 - 15.1.2P2 Taking measurements using a CRO
- 15.1.2C Competence
The trainee should have the ability to:
- i) Operate a CRO
 - ii) Take measurements using a CRO

Learning Resources

- i) Cathode-ray oscilloscope
- ii) Signal generators
- iii) Probes

15.1.3 SEMI CONDUCTOR THEORY

Theory

- 15.1.3T0 *Specific Objectives*
By the end of the sub module unit the trainee should be able to:
- a) explain intrinsic semiconductor

- b) explain effect of temperature on intrinsic semiconductor
- c) describe doping
- d) describe formation of extrinsic semiconductor

Content

- 15.1.3T1 Bond in Intrinsic semi conductors
 - i) Ge Si
 - ii) Covalent bonding
- 15.1.3T2 Temperature on intrinsic semi conductor materials
- 15.1.3T3 Doping
- 15.1.3T4 Formation of extrinsic semi conductor
 - iv) p type
 - v) n type

Practice

- 15.1.3P0 *Specific Objectives*
By the end of the sub module unit, the trainee should be able to verify the effect of temperature on a diode performance

Content

- 15.1.3P1 Verification of the effect of temperature on diode

15.1.3C Competence

- The trainee should have the ability to:
- i) Verify the effect of temperature on diodes
 - ii) Use a diode in electronic circuits

Suggested teaching/Learning Activities

- Demonstration

- Note taking
- Observation
- Practical exercise

Suggested teaching/Learning Resources

- i) Various types of diodes
- ii) Electronic tool kit
- iii) Power supply

Suggested Evaluation Methods

- Oral tests
- Timed written tests
- Assignments
- Timed practical tests

15.1.4 SEMICONDUCTOR DIODE

Theory

15.1.4T0 *Specific Objectives*
By the end of the sub module unit the trainee should able to:

- a) describe formation of PN junction
- b) explain forward and reverse bias of PN junction
- c) explain applications of semiconductor diodes

Content

15.1.4T1 Formation of an PN junction diode.

- i) Diffusion
- ii) Depletion layer
- iii) Barrier potential

15.1.4T2 Forward and reverse mode of operation of PN junction diode.

- i) Drift
- ii) Forward characteristics
- iii) Reverse characteristics
- iv) Zener Avalanche effect

15.1.4T3 Application of semiconductor diodes
i) Power diodes
ii) signal diodes

Practice

15.1.4P0 *Specific Objectives*
By the end of the sub module unit, the trainee should be able to:
a) identify the diode terminals
b) determine diode characteristics

Content

15.1.4P1 Identifying diode terminals
15.1.4P2 Determining diode characteristics

15.1.4C **Competence**
The trainee should have the ability to:
i) Identify diode terminals
ii) Determine diode characteristics

Suggested teaching/Learning Activities

- Demonstration
- Note taking
- Observation
- Practical exercise

Learning Resources

- i) Assorted semi conductor diodes
- ii) DC power supply
- iii) Multimeters
- iv) Graph paper
- v) X-ray plotter

Suggested Evaluation Methods

- Oral tests
- Timed written tests
- Assignments
- Timed practical tests

- DC load-line
- i) Gain estimates
- ii) Current, voltage and power gain
- iii) Maximum power curve.

15.1.5 BIPOLAR JUNCTION TRANSISTORS

Theory

- 15.1.5T0 *Specific Objectives*
By the end of the sub module unit the trainee should be able to:
- a) describe the construction and operation of a Bipolar Junction Transistors (BJT)
 - b) explain the characteristics of Bipolar Junction Transistor
 - c) describe the biasing methods
 - d) determine gains using DC load lines

Content

- 15.1.5T1 Construction and operation of BJTs
- i) NPN
 - ii) PNP
- 15.1.5T2 Static characteristics of BJTs
- i) Input
 - ii) Output
 - iii) Transfer
- 15.1.5T3 Transistor biasing methods
- i) Base bias
 - ii) Emitter bias
 - iii) Collector base feedback bias
 - iv) Potential divider bias
- 15.1.5T4 DC load-lines

Practice

- 15.1.5P0 *Specific Objectives*
By the end of the sub module unit the trainee should be able to:
- a) identify the type of transistors
 - b) determine static transistor characteristics
 - c) bias a transistor amplifier
 - d) construct dc loadlines

Content

- 15.1.5P1 Identifying types of transistors
- 15.1.5P2 Determining static characteristics of transistors
- 15.1.5P3 Biasing transistor amplifier
- 15.1.5P4 Constructing dc loadlines

15.1. C Competence

The trainee should have the ability to:

- i) Construct a single stage transistor amplifier
- ii) Test a single stage transistor amplifier

Suggested teaching/Learning Activities

- Illustration
- Demonstration
- Note taking

Learning Resources

- i) Power supplies
- ii) Assorted transistors
- iii) Breadboard

- Oral tests
- Timed written tests
- Assignments
- Timed practical tests

- DC load-line
- i) Gain estimates
- ii) Current, voltage and power gain
- iii) Maximum power curve.

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Theory

- 15.1.5T0 *Specific Objectives*
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 - ii) PNP
- 15.1.5T2 Static characteristics of BJTs
- i) Input
 - ii) Output
 - iii) Transfer
- 15.1.5T3 Transistor biasing methods
- i) Base bias
 - ii) Emitter bias
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 - iv) Potential divider bias
- 15.1.5T4 DC load-lines

Practice

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- a) identify the type of transistors
 - b) determine static transistor characteristics
 - c) bias a transistor amplifier
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Content

- 15.1.5P1 Identifying types of transistors
- 15.1.5P2 Determining static characteristics of transistors
- 15.1.5P3 Biasing transistor amplifier
- 15.1.5P4 Constructing dc loadlines

15.1. C Competence

- The trainee should have the ability to:
- i) Construct a single stage transistor amplifier
 - ii) Test a single stage transistor amplifier

Suggested teaching/Learning Activities

- Illustration
- Demonstration
- Note taking

Learning Resources

- i) Power supplies
- ii) Assorted transistors
- iii) Breadboard

- iv) Connecting leads
- v) Multimeters
- vi) X-Y plotter
- vii) Assorted resistors
- Observation
- Practical exercise
- Calculations
- Project work
- Role play
- Visits to industries

- ii) Source bias
- iii) Drain base feedback bias
- iv) Potential divider bias
- 15.1.6T3 DC load-lines
 - i) DC Load-line
 - ii) Estimation gain (current, voltage and power)
 - iii) Maximum power curve.

Practice

Suggested Evaluation Methods

- Oral tests
- Timed written tests
- Assignments
- Timed practical tests

15.1.6 FIELD EFFECT TRANSISTORS

Theory

- 15.1.6T0 *Specific Objectives*
By the end of the sub module unit the trainee should be able to:
- a) explain the characteristics of field effect transistor
 - b) describe the biasing methods
 - c) determine gains using dc and ac load-lines

Content

- 15.1.6T1 Construction and operation of FETs
- i) Static characteristics of fets
 - ii) Jfets
 - iii) Mosfets
 - iv) Input
 - v) Output
 - vi) Transfer
- 15.1.6T2 FETs biasing methods
- i) Gate bias

- 15.1.6P0 *Specific Objectives*
By the end of the sub module unit the trainee should be able to:
- a) identify the types of FETs
 - b) determine static FET characteristics
 - c) bias a FET
 - d) construct dc loadline

Content

- 15.1.6P1 Identifying types of FETs
- 15.1.6P2 Determination static characteristic of FETs
- 15.1.6P3 Biasing a FET amplifier
- 15.1.6P4 Construction of dc loadlines

15.1.6C Competence

The trainee should have the ability to:

- i) Construct a single stage FET amplifier
- ii) Test a single stage FET amplifier

Suggested teaching/Learning Activities

- Demonstration
- Note taking
- Observation
- Practical exercise

Suggested teaching/Learning Resources

- i) Field effect transistors
- ii) Power supply
- iii) Electronic tools
- iv) Electrical measuring instruments

Suggested Evaluation Methods

- Oral tests
- Timed written tests
- Assignments
- Timed practical tests

15.1.7 POWER SUPPLIES

Theory

15.1.7T1 *Specific Objectives*

By the end of the sub module unit the trainee should able to:

- a) describe block diagram of power supply
- b) explain principles rectification
- c) explain smoothing and filtering
- d) explain power regulation/stabilizer methods
- e) describe voltage multiplier methods
- f) describe methods of power conversion

Content

15.1.7T1 Description of the block diagram of power supply

- i) Transformation
- ii) Rectification
- iii) Filters
- iv) Regulator

15.1.7T2 Explanation of principles rectification

- i) Half wave
- ii) Full wave bi-phase

- iii) Bridge

15.1.7T3 Explanation

filtration/smoothing

- i) Capacitor filter
- ii) Inductive filtering

15.1.7T4 Explanation power regulation/stabilizer methods

- i) Zener diode regulator
- ii) Linear regulators
- iii) Switched regulators

15.1.7T5 Description of voltage multiplier methods

- i) Doubler
- ii) Tripler
- iii) Cockroft walton

15.1.7T6 Description of methods of power conversion

- i) Dc to ac
- ii) Dc to dc

Practice

15.1.7P0 *Specific Objectives*

By the end of the sub module unit the trainee should be able to:

- a) Construct a power supply unit
- b) Test a power supply unit

Content

15.1.7P1 Construction of power supply units

15.1.7P2 Testing a power supply unit

15.1.7C Competence

The trainee should have the ability to: construct and test a power supply unit

Suggested teaching/Learning Activities

- Demonstration
- Note taking
- Observation

- Practical exercise

Teaching/Learning Resources

- i) Step-down transformer
- ii) Rectifier diodes
- iii) Smoothing capacitor
- iv) Zener diode regulations
- v) Transistor regulations
- vi) IC regulators
- vii) Potentiometers
- viii) Assorted resistors

- ix) Multimeters
- x) CRP
- xi) RF bypass capacitors

Suggested Evaluation Methods

- Oral tests
- Timed written tests
- Assignments
- Timed practical tests
- Project

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